

Notice of References Cited	Application/Control No. 10/562,002		Applicant(s)/Patent Under Reexamination MURAKAMI	
	Examiner SHELLEY CHEN		Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,742,297 A	04-1998	Logan, Mark J.	345/672
*	B	US-6,006,160 A	12-1999	Tamaki et al.	701/208
*	C	US-6,023,654 A	02-2000	Mohlenkamp, Klaus	701/208
*	D	US-6,138,073 A	10-2000	Uchigaki, Yuichiro	701/208
*	E	US-2003/0182051 A1	09-2003	Yamamoto, Tetsuo	701/200
*	F	US-2004/0064958 A1	04-2004	Segur, Patrick	033/001.0CC
*	G	US-2004/0066316 A1	04-2004	Ogawa, Tsuyoshi	340/995.1
*	H	US-2005/0023524 A1	02-2005	Beatty, Bryan Kendall	257/059
*	I	US-6,961,096 B1	11-2005	Tsujimoto, Shinichi	348/552
*	J	US-7,050,903 B1	05-2006	Shutter et al.	701/117
*	K	US-7,272,500 B1	09-2007	Walker, William T.	701/213
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.